Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination HUAPAYA, LUIS	
10/663,744		
Examiner	Art Unit	
Kieu D. Vu	2173	

SEARCHED					
Class	Subclass	Date	Examiner		
715	804	6/7/2007	κv		
715	802	6/7/2007	KV		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEAR)		Y)	
	DATE	EXMR	
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR)	6/7/2007	KV	
updale search	01/22/0	01/22/08 KV	
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